

Vishay Siliconix

P-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$	I _D (A) ^d	Q _g (Typ.)		
- 30	0.0125 at V _{GS} = - 10 V	- 14.9	29.5 nC		
	0.0205 at $V_{GS} = -4.5 \text{ V}$	- 11.6	29.5110		

FEATURES

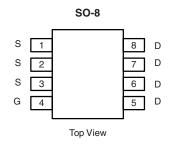
- Halogen-free
- TrenchFET[®] Power MOSFET
- 100 % R_g Tested
- 100 % UIS Tested



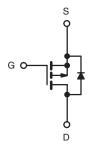
RoHS

APPLICATIONS

- Load Switch
- · Notebook Adaptor Switch







P-Channel MOSFET

Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V_{DS}	- 30	V		
Gate-Source Voltage		V_{GS}	± 25		
	T _C = 25 °C		- 14.9		
Continuous Prain Current (T = 150 °C)	T _C = 70 °C		- 11.9		
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	l _D	- 10.9 ^{a, b}		
	T _A = 70 °C		- 8.6 ^{a, b}		
Pulsed Drain Current		I _{DM}	- 60	Α	
Continuous Source-Drain Diode Current	T _C = 25 °C	1	- 4.1		
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	- 2.2 ^{a, b}		
Avalanche Current	1 0 4 mal 1	I _{AS}	- 20		
Single-Pulse Avalanche Energy L = 0.1 mH		E _{AS}	20	mJ	
	T _C = 25 °C		5.0		
Mariana Paran Dissination	T _C = 70 °C	ь	3.2	14/	
Maximum Power Dissipation	T _A = 25 °C	P _D	2.7 ^{a, b}	W	
	T _A = 70 °C		1.7 ^{a, b}		
Operating Junction and Storage Temperature Rang	T _J , T _{stq}	- 55 to 150	°C		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{a, c}	t ≤ 10 s	R_{thJA}	38	46	°C/W	
Maximum Junction-to-Foot	Steady State	R_{thJF}	20	25	C/VV	

Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- b. t = 10 s.
- c. Maximum under Steady State conditions is 85 °C/W.
- d. Based on T_C = 25 °C.

Document Number: 68926 S-82484-Rev. A, 13-Oct-08

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static						ı	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 30			V	
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J			- 34		mV/	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = - 250 μA		5.3		°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 1.4		- 2.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 25 \text{ V}$			± 100	nA	
7 0 1 1 1 5 1 5 1	I _{DSS}	$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}$			- 1	μΑ	
Zero Gate Voltage Drain Current		V _{DS} = - 30 V, V _{GS} = 0 V, T _J = 55 °C			- 5		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge -10 \text{ V}, V_{GS} = -10 \text{ V}$	- 30			Α	
	R _{DS(on)}	V _{GS} = - 10 V, I _D = - 10 A		0.010	0.0125	Ω	
Drain-Source On-State Resistance ^a		V _{GS} = - 4.5 V, I _D = - 8 A		0.0165	0.0205		
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 10 V, I _D = - 10 A		28		S	
Dynamic ^b							
Input Capacitance	C _{iss}			2550		pF	
Output Capacitance	C _{oss}	V _{DS} = - 15 V, V _{GS} = 0 V, f = 1 MHz		455			
Reverse Transfer Capacitance	C _{rss}			390			
T. 10 . 0		V _{DS} = - 15 V, V _{GS} = - 10 V, I _D = - 10 A		57	86		
Total Gate Charge	Q _g V _{DS} = 13 V, V _{GS} = 10 V, I _D = 10 A		29.5	45	nC		
Gate-Source Charge	Q_{qs} $V_{DS} = -15 \text{ V}, V_{GS} = -4.5 \text{ V}, I_D = -10 \text{ A}$		8				
Gate-Drain Charge	Q _{qd}			22			
Gate Resistance	R_g	f = 1 MHz	0.5	2.2	4.4	Ω	
Turn-On Delay Time	t _{d(on)}			13	25	-	
Rise Time	t _r	V_{DD} = - 15 V, R_L = 1.5 Ω		12	24		
Turn-Off DelayTime	t _{d(off)}	$I_{D} \cong -10 \text{ A}, V_{GEN} = -10 \text{ V}, R_{g} = 1 \Omega$		40	70		
Fall Time	t _f	Ü		9	18	1	
Turn-On Delay Time	t _{d(on)}			48	80	ns	
Rise Time	t _r	$V_{DD} = -15 \text{ V}, R_{L} = 1.5 \Omega$		92	160		
Turn-Off DelayTime	t _{d(off)}	$I_D \cong$ - 10 A, $V_{GEN} =$ - 4.5 V, $R_g = 1 \Omega$		34	60		
Fall Time	t _f	Ů		19	35		
Drain-Source Body Diode Characteris	tics						
Continous Source-Drain Diode Current	I _S	T _C = 25 °C			- 4.1	Α	
Pulse Diode Forward Current	I _{SM}	-			- 60		
Body Diode Voltage	V _{SD}	I _S = - 3 A, V _{GS} = 0 V		- 0.75	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}	0 1 00		27	45	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	1 10 A 11/44 100 A / - T 05 00		16	27	nC	
Reverse Recovery Fall Time t_a		$I_F = -10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		12		ns	
Reverse Recovery Rise Time	t _b	1	15				

Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$

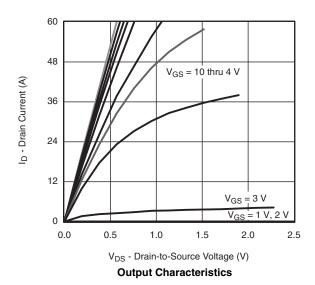
b. Guaranteed by design, not subject to production testing.

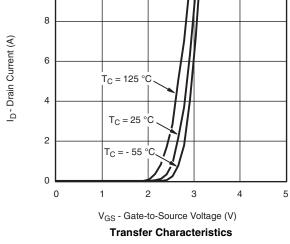
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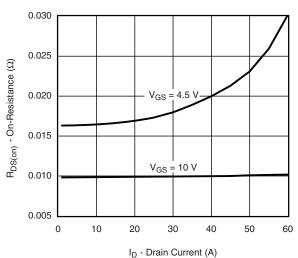


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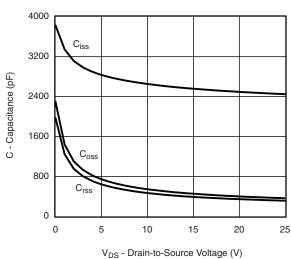
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted







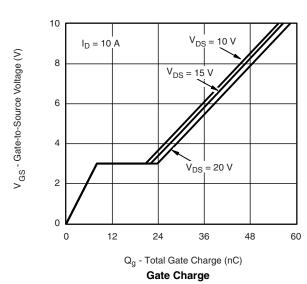
On-Resistance vs. Drain Current



1.6 10 A $I_D =$ 1.4 V_{GS} = - 10 V R_{DS(on)} - On-Resistance (Normalized) 1.2 1.0 0.8 0.6 - 50 - 25 0 25 150 50 75 100 125 T_J - Junction Temperature (°C)

Capacitance

On-Resistance vs. Junction Temperature



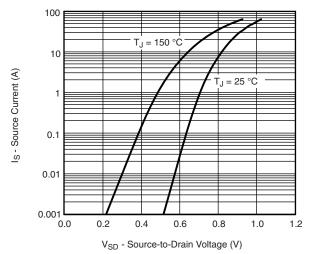
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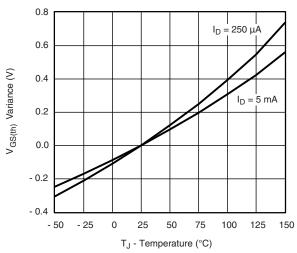
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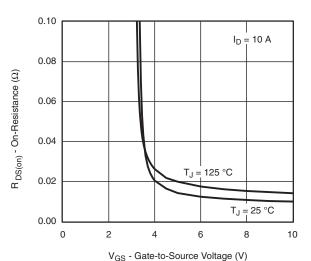
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



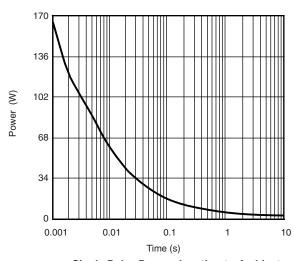
Source-Drain Diode Forward Voltage



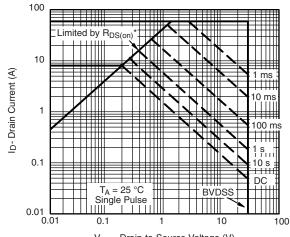
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient



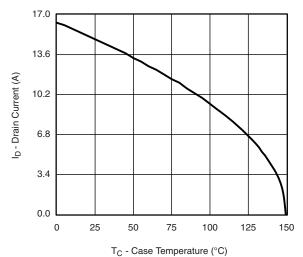
 $$V_{DS}$$ - Drain-to-Source Voltage (V) * V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

Safe Operating Area

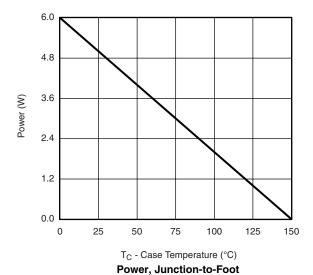


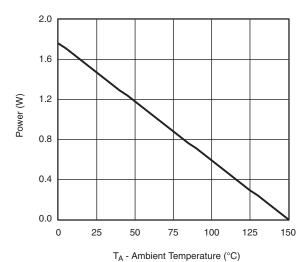
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MOSFET TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Current Derating*





Power Derating, Junction-to-Ambient

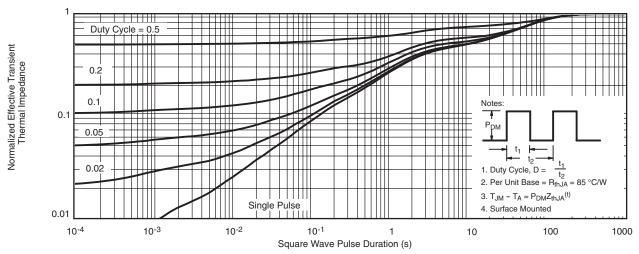
 $^{^*}$ The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package

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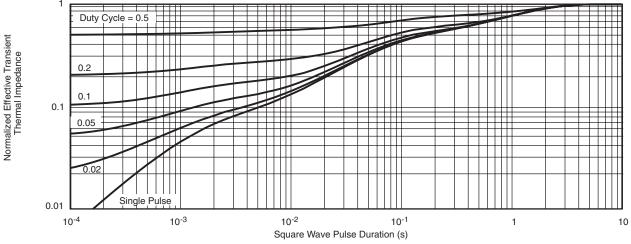
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

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Document Number: 91000 www.vishay.com
Revision: 11-Mar-11 1